

<b>Notice of References Cited</b>	Application/Control No. 10/541,236		Applicant(s)/Patent Under Reexamination SAHLBERG ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,694,150 A	12-1997	Sigona et al.	715/856
*	B	US-6,097,212 A	08-2000	Agrawal et al.	326/41
*	C	US-2001/0031066 A1	10-2001	Meyer et al.	382/100
*	D	US-2001/0033293 A1	10-2001	Hollstrom et al.	345/705
*	E	US-2001/0039542 A1	11-2001	Okada et al.	707/3
*	F	US-2002/0034300 A1	03-2002	Thuvesholmen et al.	380/256
*	G	US-2002/0040816 A1	04-2002	Sahlberg et al.	178/18.01
*	H	US-2002/0059379 A1	05-2002	Harvey et al.	709/205
*	I	US-2002/0059140 A1	05-2002	Fahraeus et al.	705/40
*	J	US-2002/0063696 A1	05-2002	Kubo et al.	345/173
*	K	US-2002/0073233 A1	06-2002	Gross et al.	709/245
*	L	US-2002/0156917 A1	10-2002	Nye, Timothy G.	709/238
*	M	US-2002/0186683 A1	12-2002	Buck et al.	370/352

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0188695 A1	12-2002	Tso, Frank	709/218
*	B	US-2002/0194183 A1	12-2002	Yoakum et al.	707/10
*	C	US-2003/0018710 A1	01-2003	Choi, Moon-Jeong	709/203
*	D	US-2003/0046589 A1	03-2003	Gregg, Richard L.	713/201
*	E	US-2003/0084116 A1	05-2003	Musante et al.	709/217
*	F	US-2003/0105812 A1	06-2003	Flowers et al.	709/203
*	G	US-6,593,908 B1	07-2003	Borgstrom et al.	345/156
*	H	US-6,611,259 B1	08-2003	Tillgren et al.	345/179
*	I	US-2003/0149737 A1	08-2003	Lambert et al.	709/214
*	J	US-2003/0177411 A1	09-2003	Dinker et al.	714/13
*	K	US-6,615,376 B1	09-2003	Olin et al.	714/57
*	L	US-6,643,824 B1	11-2003	Bates et al.	715/205
*	M	US-6,671,791 B1	12-2003	McGrath, Kevin J.	711/206

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,735,206 B1	05-2004	Oki et al.	370/395.32
*	B	US-6,748,437 B1	06-2004	Mankude et al.	709/227
*	C	US-6,810,393 B2	10-2004	Okada et al.	707/3
*	D	US-6,845,393 B1	01-2005	Murphy et al.	709/220
*	E	US-6,938,080 B1	08-2005	Kahveci et al.	709/223
*	F	US-6,944,788 B2	09-2005	Dinker et al.	714/4
*	G	US-7,050,445 B1	05-2006	Zellner et al.	370/412
*	H	US-7,047,300 B1	05-2006	Oehrke et al.	709/226
*	I	US-7,136,368 B2	11-2006	Inoue, Atsushi	370/338
*	J	US-7,266,822 B1	09-2007	Boudnik et al.	718/100
*	K	US-7,290,288 B2	10-2007	Gregg et al.	726/28
*	L	US-7,302,471 B2	11-2007	Hall, Rob	709/206
*	M	US-7,386,751 B2	06-2008	Cheng et al.	714/1

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,440,996 B2	10-2008	Gebhart, Alexander	709/203
*	B	US-7,457,413 B2	11-2008	Thuvesholmen et al.	380/46
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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